FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE			ATTY DOCKET NO. 03500.017883	APPLICATION NO. 10/769,765		
LIST	PATENT AND TRADEMARK OF REFERENCES CITED BY	OFFICE APPLICANTS I PE	PPLICANT HIROSHI AOTO ET AL.			
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FOREIGN PATENT DOCUMENTS						
·	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
mm	2002-86461	11/2002	Korea		_	Abstract
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Sheet 1 of 1

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.